Search Notes

Applicati	ion/Co	ntrol No.

Applicant(s)/Patent under Reexamination

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Examiner

NAKAHARA, SHIGEKI Art Unit

Madeleine AV Nguyen

2625

	SEARCHED		
Class	Subclass	Date	Examiner
East		4/10/2007	AV

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH (INCLUDING SEAR	NOTES CH STRATEGY	')
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